

**Notice of References Cited**

Application/Control No.  
09/800,776

Applicant(s)/Patent Under  
Reexamination  
YAMANOUCHI ET AL.

Examiner  
Callie E. Shosho

Art Unit  
1714

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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